

# AAT7551 20V P-Channel Power MOSFET

### **General Description**

The AAT7551 is a dual low threshold P-channel MOSFET designed for the battery, cell phone, and PDA markets. Using AnalogicTech's ultra-high-density MOSFET process and space-saving, small outline, J-lead package, performance superior to that normally found in a TSOP-6 footprint has been squeezed into the footprint of an SC70JW-8 package.

# **Applications**

- Battery Packs
- Battery-Powered Portable Equipment
- Cellular and Cordless Telephones

# Absolute Maximum Ratings

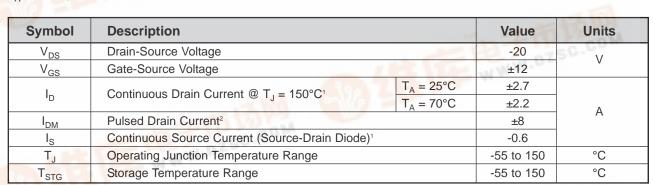
 $T_A = 25$ °C, unless otherwise noted.

# Top View D1 D1 D2 D2 8 7 6 5

### **Features**

- Drain-Source Voltage (max): -20V
- Continuous Drain Current¹ (max):
   -2.7A @ 25°C
- Low On-Resistance:
  - 100mΩ @ V<sub>GS</sub> = -4.5V
  - 175mΩ @ V<sub>GS</sub> = -2.5V

### **Dual SC70JW-8 Package**



# Thermal Characteristics<sup>1</sup>

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Symbol	Description		Тур	Max	Units	
$R_{\theta JA}$	Junction-to-Ambient Steady State		132	165	°C/W	
R <sub>0JA2</sub>	Junction-to-Ambient t<5 Seconds		83	104		
$R_{\theta JF}$	Junction-to-Foot		60	72		
P <sub>D</sub>	Maximum Power Dissipation	T <sub>A</sub> = 25°C		1.2	W	
		T <sub>A</sub> = 70°C		0.75	VV	

<sup>1.</sup> Based on thermal dissipation from junction to ambient while mounted on a 1" x 1" PCB with optimized layout. A 5-second pulse on a 1" x 1" PCB approximates testing a device mounted on a large multi-layer PCB as in most applications.  $R_{\theta JF} + R_{\theta FA} = R_{\theta JA}$  where the foot thermal reference is defined as the normal solder mounting surface of the device's leads.  $R_{\theta JF}$  is guaranteed by design; however,  $R_{\theta CA}$  is determined by the PCB design. Actual maximum continuous current is limited by the application's design. Pulse test: Pulse Width = 300 $\mu$ s.

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#### **Electrical Characteristics**

 $T_{\perp} = 25^{\circ}C$ , unless otherwise noted.

Symbol	Description	Conditions	Min	Тур	Max	Units		
DC Characteristics								
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_{D} = -250\mu A$	-20			V		
R <sub>DS(ON)</sub>	Drain-Source On-Resistance <sup>1</sup>	$V_{GS} = -4.5V$ , $I_D = -2.7A$ $V_{GS} = -2.5V$ , $I_D = -2.0A$		80 140	100 175	mΩ		
I <sub>D(ON)</sub>	On-State Drain Current <sup>1</sup>	$V_{GS} = -4.5V$ , $V_{DS} = -5V$ (pulsed)	-8			Α		
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = -250\mu A$	-0.6			V		
I <sub>GSS</sub>	Gate-Body Leakage Current	$V_{GS} = \pm 12V$ , $V_{DS} = 0V$			±100	nA		
I <sub>DSS</sub>	Drain Source Leakage Current	$V_{GS} = 0V, V_{DS} = -20V$ $V_{GS} = 0V, V_{DS} = -16V, T_{J} = 70^{\circ}C^{2}$			-1 -5	μΑ		
g <sub>fs</sub>	Forward Transconductance <sup>1</sup>	$V_{DS} = -5V, I_{D} = -2.7A$		4		S		
Dynamic	Dynamic Characteristics <sup>2</sup>							
$Q_{G}$	Total Gate Charge	$V_{DS} = -10V, R_D = 3.7\Omega, V_{GS} = -4.5V$		5.9				
Q <sub>GS</sub>	Gate-Source Charge	$V_{DS} = -10V, R_D = 3.7\Omega, V_{GS} = -4.5V$		1		nC		
Q <sub>GD</sub>	Gate-Drain Charge	$V_{DS} = -10V, R_D = 3.7\Omega, V_{GS} = -4.5V$		2				
t <sub>D(ON)</sub>	Turn-On Delay	$V_{DS} = -10V$ , $R_D = 3.7\Omega$ , $V_{GS} = -4.5V$ , $R_G = 6\Omega$		22				
t <sub>R</sub>	Turn-On Rise Time	$V_{DS} = -10V$ , $R_{D} = 3.7\Omega$ , $V_{GS} = -4.5V$ , $R_{G} = 6\Omega$		10		ns		
t <sub>D(OFF)</sub>	Turn-Off Delay	$V_{DS} = -10V$ , $R_{D} = 3.7\Omega$ , $V_{GS} = -4.5V$ , $R_{G} = 6\Omega$		20		115		
t <sub>F</sub>	Turn-Off Fall Time	$V_{DS} = -10V$ , $R_D = 3.7\Omega$ , $V_{GS} = -4.5V$ , $R_G = 6\Omega$		40				
Source-Drain Diode Characteristics								
V <sub>SD</sub>	Source-Drain Forward Voltage <sup>1</sup>	$V_{GS} = 0$ , $I_{S} = -2.7A$			-1.3	V		
Is	Continuous Diode Current <sup>3</sup>				-0.6	Α		

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<sup>1.</sup> Pulse test: Pulse Width = 300µs.

<sup>2.</sup> Guaranteed by design. Not subject to production testing.

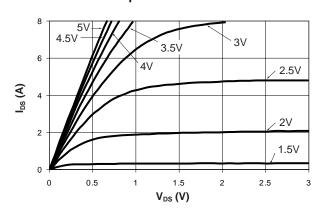
<sup>3.</sup> Based on thermal dissipation from junction to ambient while mounted on a 1" x 1" PCB with optimized layout. A 5-second pulse on a 1" x 1" PCB approximates testing a device mounted on a large multi-layer PCB as in most applications.  $R_{\theta JF} + R_{\theta FA} = R_{\theta JA}$  where the foot thermal reference is defined as the normal solder mounting surface of the device's leads.  $R_{\theta JF}$  is guaranteed by design; however,  $R_{\theta CA}$  is determined by the PCB design. Actual maximum continuous current is limited by the application's design.



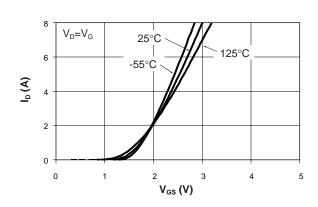
## **Typical Characteristics**

 $T_1 = 25^{\circ}$ C, unless otherwise noted.

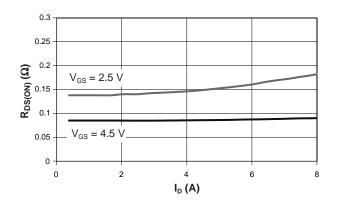
#### **Output Characteristics**



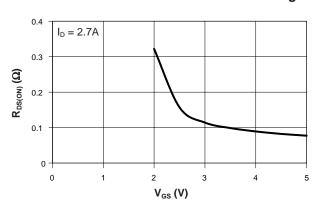
#### **Transfer Characteristics**



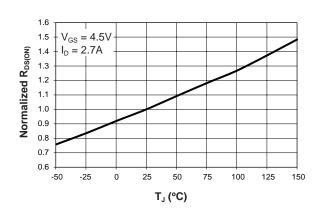
**On-Resistance vs. Drain Current** 



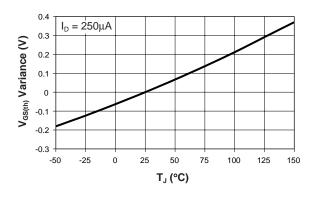
On-Resistance vs. Gate-to-Source Voltage



**On-Resistance vs. Junction Temperature** 



Threshold Voltage



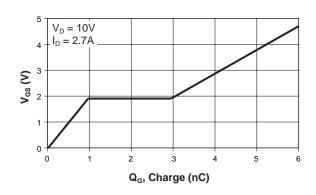
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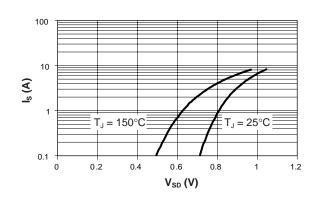
# **Typical Characteristics**

 $T_{\perp} = 25^{\circ}$ C, unless otherwise noted.

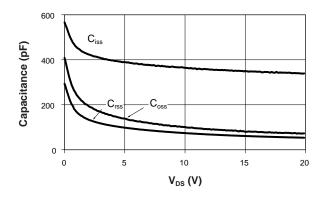
#### **Gate Charge**



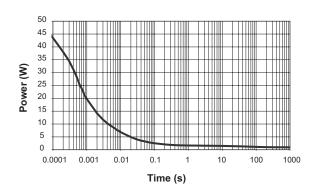
#### **Source-Drain Diode Forward Voltage**



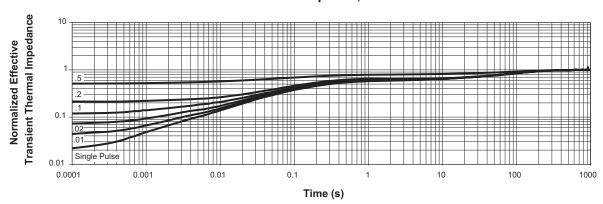
#### Capacitance



#### Single Pulse Power, Junction to Ambient



#### **Transient Thermal Response, Junction to Ambient**



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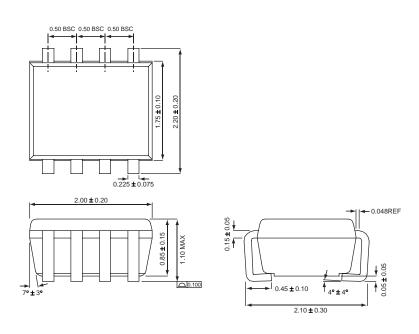


# **Ordering Information**

Package	Marking <sup>1</sup>	Part Number (Tape and Reel) <sup>2</sup>
SC70JW-8	KDXYY	AAT7551IJS-T1

# **Package Information**

#### **SC70JW-8**



All dimensions in millimeters.

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<sup>1.</sup> XYY = assembly and date code.

<sup>2.</sup> Sample stock is generally held on part numbers listed in **BOLD**.



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